

JADE Pro JADE Pro is all-inclusive!

JADE Pro includes all of the features of JADE Standard, plus batch processing Whole Pattern Fitting (WPF) and Rietveld refinement tools that go beyond what is available in JADE Standard. JADE's One-Click-AnalysisTM and the JADE Toolkit are only found in JADE Pro. Additionally, JADE Pro features a

unique floating network license that allows access on one concurrent system at a time, so when a license is not in use, it is available to someone else in your organization. Discounted additional seats create access to more concurrent shareable licenses that work together.



- All-inclusive Everything in JADE Standard and so much more
- Phase ID (Search/Match)
- Batch processing Whole Pattern Fitting (WPF) and Rietveld
- One-Click-Analysis™ for Whole Pattern Fitting (WPF)
- Pattern Indexing (All Crystal Systems)
- Rietveld Structure Refinement (Atomic Parameters)
- Ab Initio Tools (Charge Flipping +)
- Cluster Analysis of Powder Patterns
- Hardware Independent supports a wide range of diffractometers
- Floating Network License can work as a shareable multi-seat license
- Discounted Additional Seats Available



JADE Standard

JADE Standard provides a more limited set of tools than JADE Pro but without the annual updates and renewal costs. Available in three levels -

- 1. Basic Level
- 2. Add either Phase ID (S/M) or WPF + Rietveld
- 3. Add both Phase ID (S/M) and WPF + Rietveld.

Simulation and Visualization - All levels of JADE Standard Simulate powder patterns to create your own custom database. Visualize a structure in 3D with motion. Visual cues throughout to better help you and your team understand the materials you are analyzing.

Phase ID (S/M) - JADE Standard Level 2A or Level 3 Profile-based Search/Match with minor and trace phase ID or search on a single peak. Ability to include chemistry filters and unit cell data as well as preferred-orientation.

WPF + RIETVELD - JADE Standard Level 2B or Level 3 Quantify weight percentages and identify minor phases quickly and easily.



Level 1

Base







Level 2 (A or B)		Level 3
Base	Base	Base
Phase ID (S/M)		Phase ID (S/M)
	WPF + Rietveld	WPF + Rietveld

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KEY POINTS - ALL LEVELS

- Reads all vendor pattern files
- Handles variable/fixed-slit data
- Auto peak search and multi-filter search
- Simulate powder patterns from crystal structures
- No annual renewal fee
- Individually licensed for workstations
- Hardware Independent supports a wide range of diffractometers

PHASE ID (SEARCH/MATCH)

- Found in Levels
 2A: Search/Match
 3: Search/Match and Whole Pattern Fitting
- Phase Identification (S/M)
- Minor and Trace Phase ID



JADE QA

Built for production line Quantitative Analysis (QA) typically carried out by a technician. Requires a setup file created by an analytical scientist using JADE Pro. JADE QA runs independently of JADE Pro and was designed to extend the power of Rietveld Quantitative Analysis (QA) to those in your organization responsible for overseeing consistencies in production who may or may not have a background in XRD.

WPF + RIETVELD

- Found in Levels
 2B: Whole Pattern Fitting (WPF)
 3: Search/Match and WPF
- WPF & Rietveld Refinement